8259A

Programmable Interrupt Controller iAPX86 Family MILITARY INFORMATION

DISTINCTIVE CHARACTERISTICS

SMD/DESC qualified

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- Eight-level priority controller
- Expandable to 64 levels
- Programmable interrupt modes

- Individual request mask capability
- Single +5-V supply (no clocks)
- 28-pin dual-in-line package

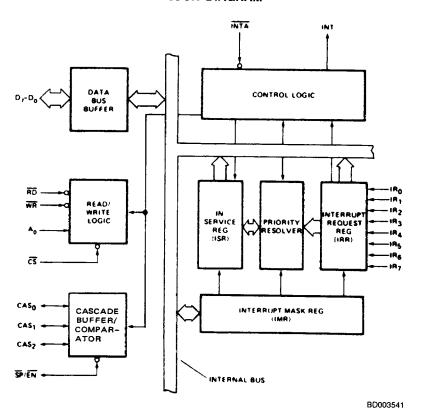
GENERAL DESCRIPTION

The 8259A Programmable Interrupt Controller handles up to eight vectored priority interrupts for the CPU. It is cascadable for up to 64 vectored priority interrupts without additional circuitry. It is packaged in a 28-pin DIP, uses NMOS technology, and requires a single +5-V supply. Circuitry is static, requiring no clock input.

The 8259A is designed to minimize the software and realtime overhead in handling multi-level priority interrupts. It has several modes, permitting optimization for a variety of system requirements.

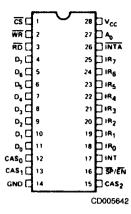
The 8259A is fully upward-compatible with the 8259. Software originally written for the 8259 will operate the 8259A in all 8259-equivalent modes.

BLOCK DIAGRAM



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CONNECTION DIAGRAM Top View



Note: Pin 1 is marked for orientation.

MILITARY ORDERING INFORMATION

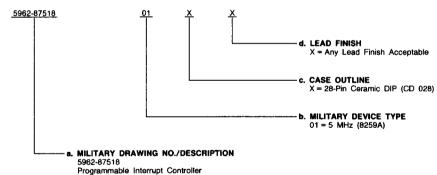
Standard Military Drawing (SMD)/DESC Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. Standard Military Drawing (SMD)/DESC products are fully compliant with MIL-STD-883C requirements. The order number (Valid Combination) for SMD/DESC products is formed by a combination of: a. Military Drawing Part Number

b. Device Type

c. Case Outline

d. Lead Finish



Valid Combinations 5962-8751801 XX

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations or to check for newly released valid combinations.

Group A Tests

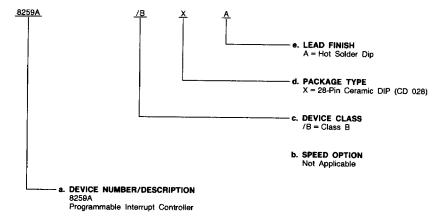
Group A tests consist of Subgroups 1, 2, 3, 7, 8, 9, 10, 11.

MILITARY ORDERING INFORMATION (Cont'd.)

APL Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883C requirements. The order number (Valid Combination) for APL products is formed by a combination of: a. **Device Number**

- b. Speed Option (if applicable)
- c. Device Class
- d. Package Type
- e. Lead Finish



Valid Combinations 8259A /BXA

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations or to check for newly released valid combinations.

Group A Tests

Group A tests consist of subgroups 1, 2, 3, 7, 8, 9 10, 11.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature65	to	+	150	°C
Voltage on Any Pin				
with Respect to Ground0.5	V.	to	+7	٧
Power Discination			1	W

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Military (M) Devices		
Temperature (T _C)55	to	125°C
Supply Voltage (V _{CC}) 5	V ±	10%

Operating ranges define those limits between which the functionality of the device is guaranteed.

DC CHARACTERISTICS over operating range (for SMD/DESC and APL Products, Group A, Subgroups 1, 2, 3 are tested unless otherwise noted)

Parameter Symbol	Parameter Description	Test Conditions	Min.	Max.	Unit
V _{IL}	Input LOW Voltage	V _{CC} = 4.5 V to 5.5 V	-0.5*	0.8	٧
VIH	Input HIGH Voltage	V _{CC} = 4.5 V to 5.5 V	2.3	V _{CC} + 0.5 V*	٧
V _{OL}	Output LOW Voltage	I _{OL} = 2.2 mA, V _{CC} = 4.5 V	4	0.45	٧
V _{OH}	Output HIGH Voltage	I _{OH} = -400 μA, V _{CC} = 4.5 V	2.4		٧
VOH(INT) Interrupt Output HIGH Voltage	International Michigan	I _{OH} = -100 μA, V _{CC} = 40 V	3,5		٧
	Interrupt Output High Voltage	I _{OH} = -400 μ/ V _{CC} -4.5 V	2.4		٧
I _{EI}	Input Load Current	V 5 N = 5.5 (pd 0 V	-10	+ 10	μΑ
LOL, LOH	Output Leakage Current	V 5 V, UT = 5.5 V and 0.45 V	-10	+10	μΑ
lcc	V _{CC} Supply Current	Vo = 5.0 V (Note 1)		125	mA

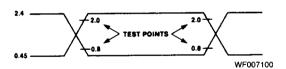
Notes: 1. ICC measured in a static condition with autput in worst-case state, having standard IOL/IOH loads applied.

CAPACITANCE (TARREST OF VCC = GND = 0 V)

Parameter Symbol	Parameter Description	Test Conditions	Min.	Max.	Unit
C _{IN} †	Input Capacitance	fc = 1 MHz		10*	pF
Ci/ot	I/O Capacitance	Unmeasured pins returned to VSS		20*	pF

*Guaranteed by design; not tested. †Not included in Group A tests.

SWITCHING TEST WAVEFORM



Input/Output

Note: AC testing inputs are driven at 2.4 V for a logic "1" and 0.45 V for a logic "0." Timing measurements are made at 2.0 V for a logic "1" and 0.8 V for a logic "0."

SWITCHING CHARACTERISTICS over operating range (for SMD/DESC and APL Products, Group A, Subgroups 9, 10, 11 are tested unless otherwise noted).

Parameter No. Symbol			8259A			
			Test Conditions	Min.	Max.	Unit
TIMING	REQUIREMENT	S				
1	t _{AHRL}	A ₀ /CS Setup to RD/INTA:		0		ns
2	†RHAX	A ₀ /CS Hold after RD/INTA:		0		ns
3	t _{RLRH}	RD Pulse Width		235		ns
4	tAHWL	A ₀ /CS Setup to WR		0		ns
5	twhax	A ₀ /CS Hold after WR1		0		ns
6	twLwH	WR Pulse Width		290		ns
7	†DVWH	Data Setup to WR:	(Note 1)	240		ns
8	twnox	Data Hold after WR!	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	0		ns
9	t _{JLJH}	Interrupt Request Width (LOW)	**	100		ns
10	[‡] CVIAL	Cascade Setup Second or Third INTA! (Slave Only)		55		ns
11	†AHAL	End of RD to next Command	1	300		ns
12	IWHRL	End of WR to next Com]	370		ns
TIMING	RESPONSES					
13	IRLOV	Data Valid from ADA TAL			200	ns
14	¹ RHDZ	Data Float after D/IN 1]	10	100	ns
15	Uнiн	Interrupt htput Delay			350	ns
16	TIALCV	Castao Va on First INTA			565	ns
17	taler	age stive from RD1 or INTA1	(Notes 1 and 2)		125	ns
18	t _{RHEH}	Inactive from RD1 or INTA1]		150	ns
19	tAHDV	Data Valid from Stable Address]		200	ns
20	tcvpv	Cascade Valid to Valid Data			300	ns

Notes: 1. Test Conditions: V_{CC} = 4.5 V to 5.5 V V_{IL} = 0.45 V, V_{IH} = 2.4 V; V_{OL} = 0.8 V, V_{OH} = = 2.0 V V_{OL} = 2.2 mA, V_{OH} = -2.0 V V_{OH} = -2.0 PF.

